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Fast component in the Xe-dopant LAr

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We proposed the first experimental confirmation of the fast component reemitence in the Xe-doped LAr. The effect is clearly visible at the concentration of more than 100 ppm Xe (mol by mol). Previously observed improvement of PSD ability with the increasing of Xe concentration in LAr by different experimental groups is explained by this effect. Advantages of Xe-dopant as a WLS for LAr-detectors are discussed.

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